



U.S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE

## LIST OF REFERENCES CITED BY APPLICANT

Docket No.: 4925-58

Filing Date: February 13, 2001

Serial No.: 09/781,990

Group Art:

Applicant: Antti FORSTADIUS et al.

## U.S. PATENT DOCUMENTS

*Ex. Inits.		Document No.	Date	Name	Class	Subclass	Filing Date
AA		5,673,031	09/30/1997	Meier	340	825.08	07/05/1994
AB		6,006,090	12/21/1999	Coleman et al.	455	432	04/28/1993
AC		6,046,992	04/04/2000	Meier et al.	370	338	04/24/1998
AD							
AE							

## FOREIGN PATENT DOCUMENTS

*Ex. Inits.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
AF		WO 00/69186	11/16/2000	PCT	Smolentsov et al.	H04Q	7/20	Yes
AG		WO 01/13660	02/22/2001	PCT	Line et al.	H04Q	7/32	Yes
AH		WO 98/19400	05/07/1998	PCT	Tikalsky	H04B	1/713	Yes
AI								
AJ								

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AK		
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AM		

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*Ex. Inits.	Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
AF	11-272997	3/24/1998	Japan		G08G	1/14	Yes
AG							
AH							
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AJ							

### OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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	AA						
	AB						
	AC						
	AD						
	AE						

### FOREIGN PATENT DOCUMENTS

*Ex. Incls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
Hee	AF	WO 01/43362	6/14/01	WIPO	Larsson et al.	H04L	12/28	No
Hee	AG	WO 01/43372	6/14/01	WIPO	Rune et al.	H04L	12/56	No
Hee	AH	WO 01/43371	6/14/01	WIPO	Rune	H04L	12/56	No
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	AJ							

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*Ex. Ints.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						

## FOREIGN PATENT DOCUMENTS

*Ex. Ints.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
Hee	AF	WO 01/28157 A2	04/19/2001	PCT	Jamieson et al.	H04L	12/00	Yes
Hee	AG	WO 01/28156 A2	04/19/2001	PCT	White	H04L	12/00	Yes
	AH							
	AI							
	AJ							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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Serial No.: n/a

Group Art:

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09/781990  
02/13/01

## U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						

## FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
	AC	✓ 98/17032	04/23/98	WO	Borgstahi et al	H04L	12/28	Yes
	AD	✓ 98/35453	08/13/98	WO	Kubler et al.	H04B	7/00	Yes
	AE	✓ 94/15413	07/07/94	WO	Mahany et al.	H04B	7/204	Yes
	AF	✓ 98/2764	06/25/98	WO	Hughes et al.	H04L	12/56	Yes
	AG	✓ 99/21095	04/29/99	WO	Cudak et al.	G06F	13/00	Yes
	AH	✓ 00/18025	03/30/00	WO	Keral et al.	H04B	1/16	Yes
	AI	✓ 11-272997	3/24/1998	Japan		G08G	1/14	No
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